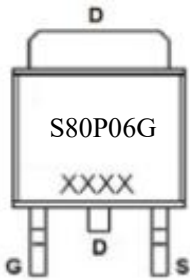
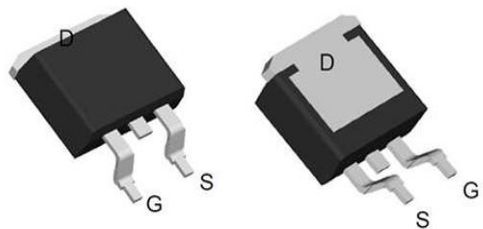
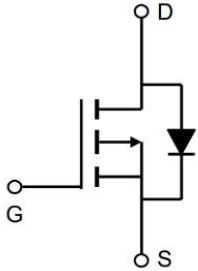


Features ➤ Split Gate Trench MOSFET technology ➤ Excellent package for heat dissipation ➤ High density cell design for low $R_{DS(ON)}$	<i>Bvdss</i>	<i>Rdson</i>	<i>ID</i>
	-60V	9mΩ	-80A
	Application ➤ DC-DC Converters ➤ Synchronous-rectification applications ➤ Power management functions		



Package  Marking and pin assignment	 TO-263 top view	 Schematic diagram
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Package Marking and Ordering Information

Device Marking	Device	Device Package	Quantity
80P06	S80P06G	TO-263	800

Absolute Maximum Ratings ($T_J=25^{\circ}\text{C}$ unless otherwise specified)

Parameter		Symbol	Value	Unit
Drain-Source Voltage		V_{DS}	-60	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_C=25^{\circ}\text{C}$	I_D	-80	A
	$T_C=100^{\circ}\text{C}$	I_D	-50	A
Pulsed Drain Current		I_{DM}^1	-320	A
Single Pulse Avalanche Energy		E_{AS}^2	450	mJ
Power Dissipation	$T_C = 25^{\circ}\text{C}$	P_D	110	W
Operating junction and storage temperature		T_J, T_{STG}	150, -55 ~ 150	$^{\circ}\text{C}$
Maximum Temperature for Soldering		T_L	300	$^{\circ}\text{C}$



Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-Case	$R_{\theta JC}$	1.1	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction -to-Ambient	$R_{\theta JA}$	60	$^{\circ}\text{C}/\text{W}$

Ordering Information

Ordering Number	Package	Pin Assignment			Packing
Halogen Free		G	D	S	
HLS80P06G	TO-263	1	2	3	Tape Reel

Electrical Characteristics ($T_j=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{V}, I_D = -250\mu\text{A}$	-60	-	-	V
Gate-body Leakage current	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 20\text{V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -60\text{V}, V_{GS} = 0\text{V}$	-	-	1	μA
Gate-Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D = -250\mu\text{A}$	-1.3	-1.8	-2.3	V
Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS} = -10\text{V}, I_D = -20\text{A}$	-	9	11	m Ω
		$V_{GS} = -4.5\text{V}, I_D = -15\text{A}$	-	12	16	
Forward Transconductance	g_{fs}	$V_{DS} = -5\text{V}, I_D = -20\text{A}$	50	-	-	S
Input Capacitance	C_{ISS}	$V_{DS} = -30\text{V}, V_{GS}=0\text{V},$ $f = 1\text{MHz}$	-	3060	-	pF
Output Capacitance	C_{OSS}		-	620	-	
Reverse Transfer Capacitance	C_{RSS}		-	20	-	
Gate Resistance	R_g	$V_{GS}=0\text{V}, V_{DS}$ Open	-	2	-	Ω
Total Gate Charge	Q_g	$V_{GS} = -10\text{V}, V_{DS} = -30\text{V}, I_D = -20\text{A}$	-	56	-	nC
Gate-Source Charge	Q_{gs}		-	11	-	
Gate-Drain Charge	Q_{gd}		-	9	-	
Turn-On Delay Time	$T_{d(on)}$	$V_{GS} = -10\text{V}, V_{DS} = -30\text{V},$ $R_G = 3\Omega, I_D = -20\text{A}$ $R_L = 0.75\Omega$	-	4.5	-	ns
Rise Time	T_R		-	2.5	-	
Turn-Off Delay Time	$T_{d(off)}$		-	14.5	-	
Fall Time	T_F		-	3.5	-	
Diode Forward Current	I_S	$T_C=25^{\circ}\text{C}$	-	-	-80	A
Diode Pulse Current	I_{SM}		-	-	-320	A
Diode Forward Voltage	V_{SD}	$I_S=-6\text{A}, V_{GS}=0\text{V}$	-	-	-1.2	V



Reverse Recovery time	T_{rr}	$I_S = -20A, V_{DD} = -30V$ $dI/dt = 100A/\mu s$	-	60	-	ns
Reverse Recovery Charge	Q_{rr}		-	105	-	nC

Note :

1.Repetitive rating; pulse width limited by maximum junction temperature

2. $V_{DD} = 30V$, $L = 0.3mH$, $R_G = 25\Omega$, Starting $T_J = 25^\circ C$

Typical Performance Characteristics

Fig1:Typ. output characteristics

$$I_D = f(-V_{DS})$$

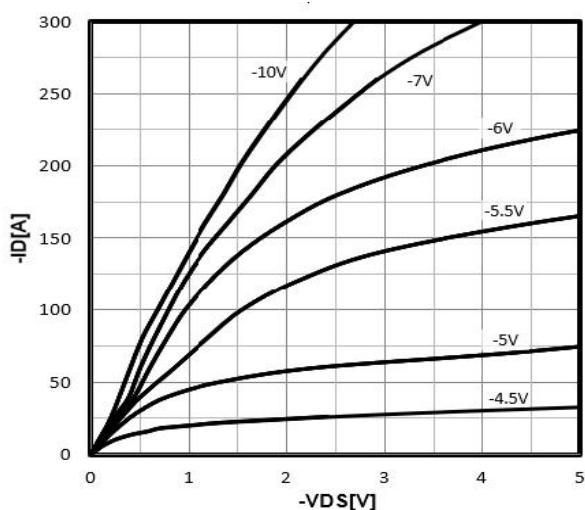


Fig2:Typ. drain-source on resistance

$$R_{DS(on)} = f(-I_D)$$

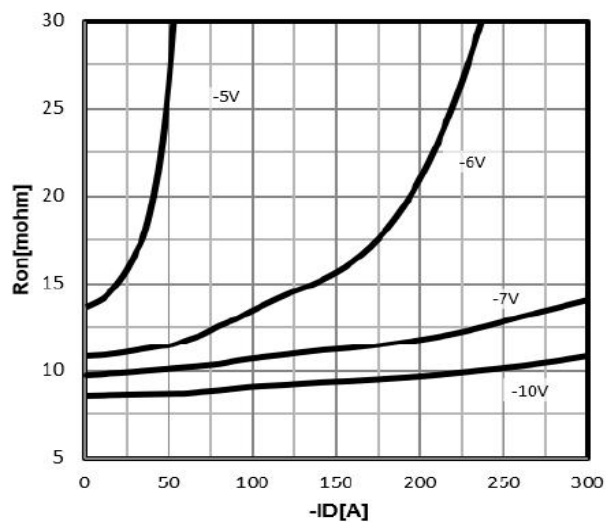


Fig3:Typ. transfer characteristics

$$-I_D = f(-V_{GS})$$

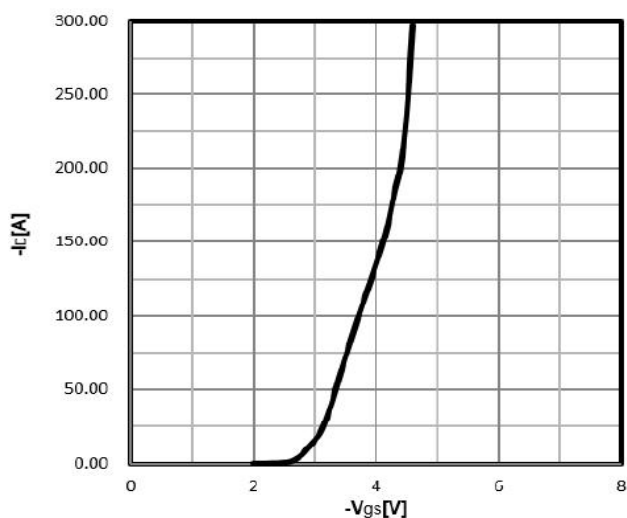


Fig4:Typ. forward transconductance

$$g_{fs} = f(I_D)$$

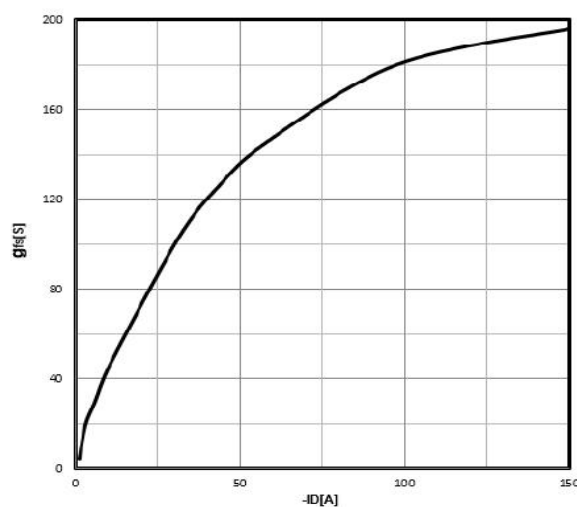


Fig5: Drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = -20A; V_{GS} = -10V;$$

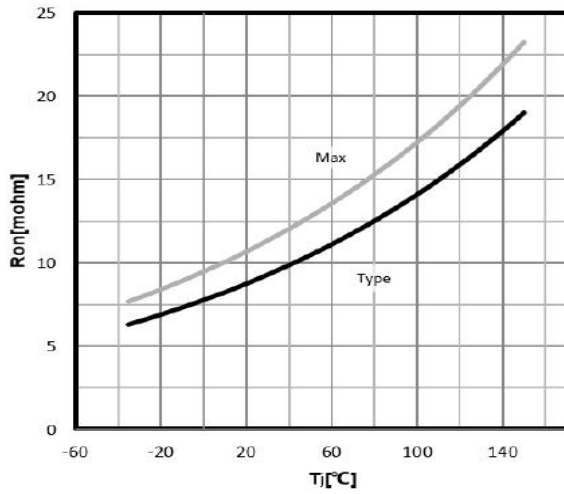


Fig6: Typ. capacitances

$$C = f(V_{DS}); V_{GS} = 0V; f = 1MHz;$$

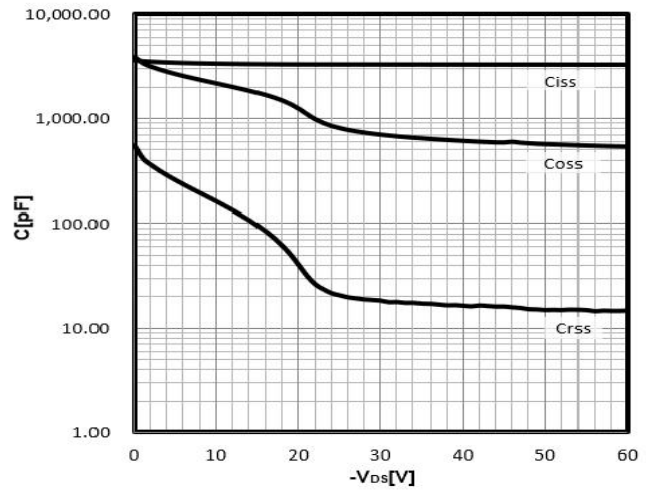


Fig7: Typ. gate charge

$$V_{GS} = f(Q_g), I_D = -20A;$$

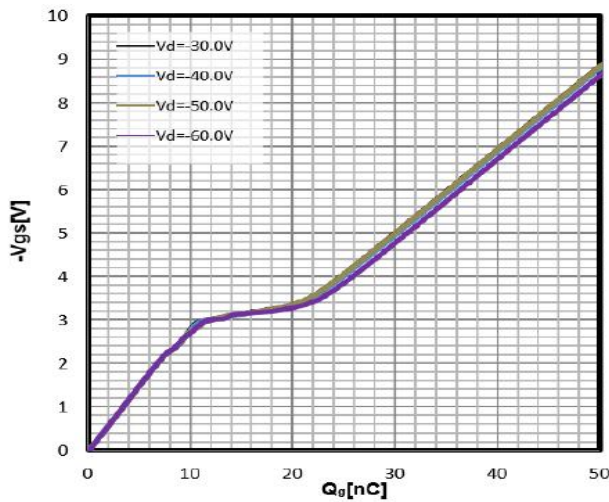


Fig8: Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = -250\mu A;$$

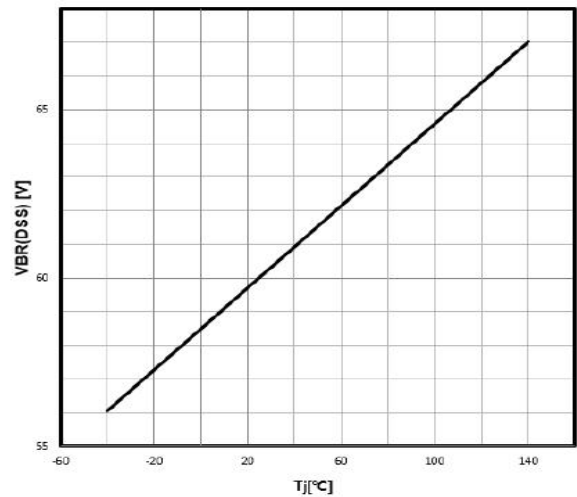


Fig9: Power Dissipation

$$P_{tot} = f(T_c)$$

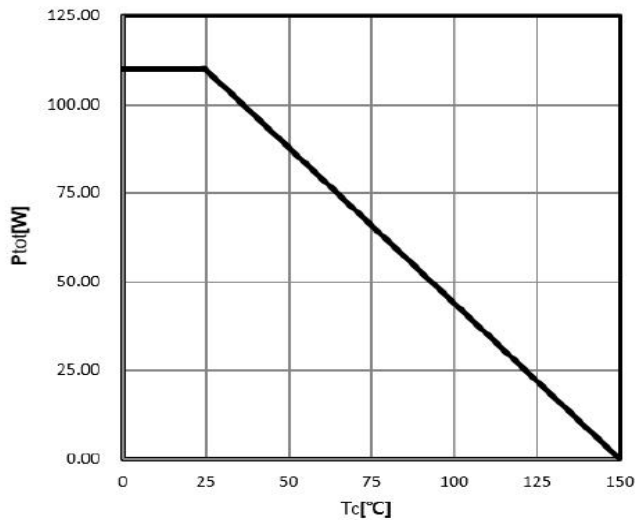


Fig10: Safe operating area

$$I_D = f(V_{DS})$$

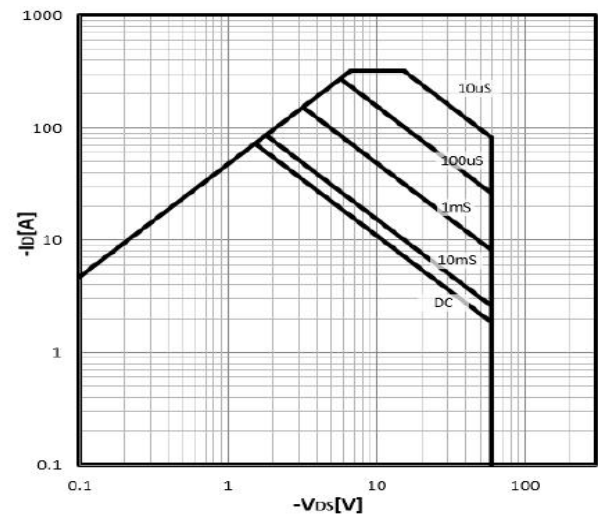
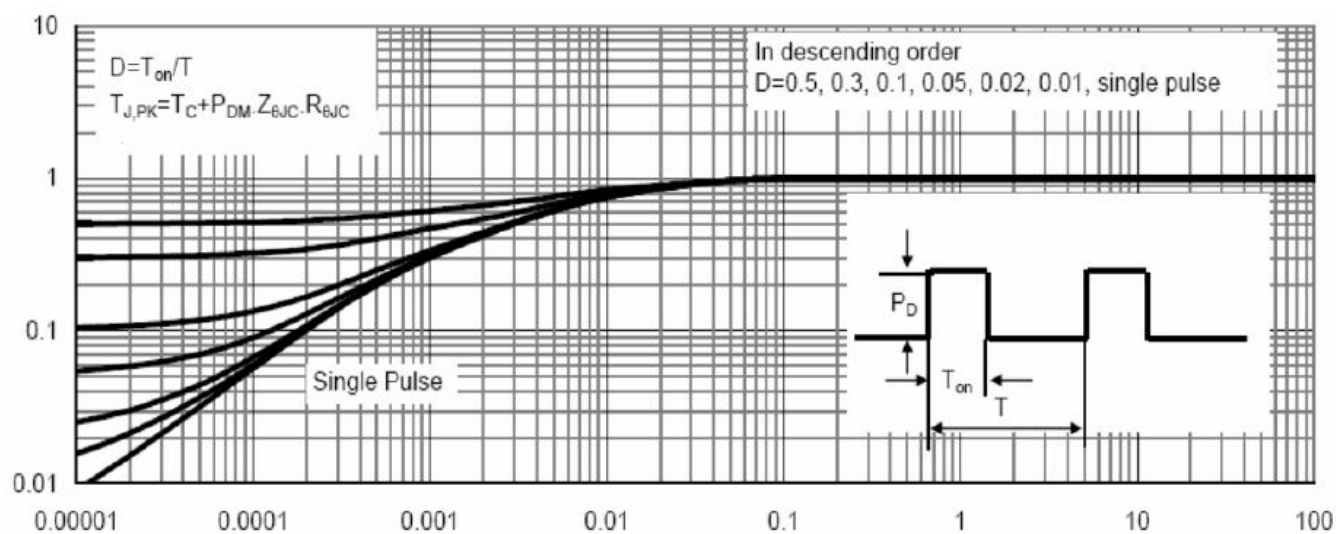


Figure 11: Max. Transient Thermal Impedance

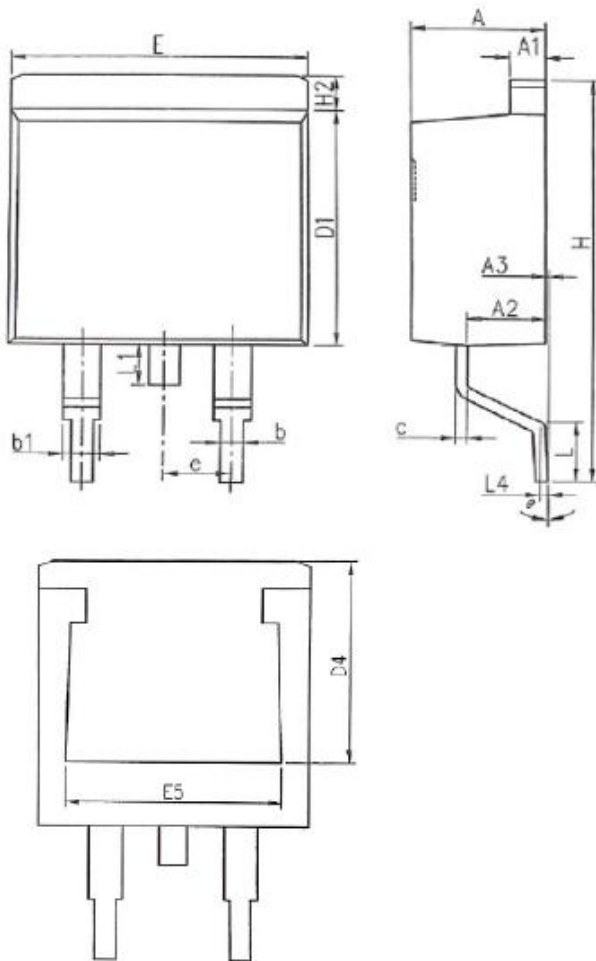
$$Z_{thJC}=f(t_p)$$





Package Dimensions TO263

COMMON DIMENSIONS



SYMBOL	MM	
	MIN	MAX
A	4.37	4.89
A1	1.17	1.42
A2	2.20	2.90
A3	0.00	0.25
b	0.70	0.96
b1	1.17	1.47
c	0.28	0.60
D1	8.45	9.30
D4	6.60	-
E	9.80	10.40
E5	7.06	-
e	2.54BSC	
H	14.70	15.70
H2	1.07	1.47
L	2.00	2.80
L1	-	1.75
L4	0.254BSC	
θ	0°	9°



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